Application/Control No. Applicant(s)/Patent Under Reexamination 09/987,034 HAYAMI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2638 **Emmanuel Bayard U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,995,707 11-1999 Α Lee, Je-Hyoung 386/81 US-6,118,904 09-2000 Detch et al. В 382/245 US-С D US-US-Ε F US-US-G US-Н US-

FOREIGN PATENT DOCUMENTS

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